

**Search Notes**

Application/Control No.

10/665,071

Examiner

Alissa L. Hoey

Applicant(s)/Patent under  
Reexamination

LIN, CHE-WEN

Art Unit

3765

**SEARCHED**

Class	Subclass	Date	Examiner
2	455, 46	8/17/2005	ALH
2	22, 23		
2	51, 61		
2	69, 72		
2	82-89		
2	93, 94		
2	101, 242		
2	244, 249		
2	250, 269		
2	911		
36	2R	8/17/2005	ALH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	8/17/2005	ALH
PLUS Search	8/17/2005	ALH